

MBM250H33E3

Silicon N-channel IGBT 3300V E3 version

FEATURES

- * Soft switching behavior & low conduction loss:
 - Soft low-injection punch-through
 - High conductivity IGBT.
- * Low driving power due to low input capacitance MOS gate.
- * Low noise recovery: Ultra soft fast recovery diode.

ABSOLUTE MAXIMUM RATINGS (T_C=25°C)

Item	Symbol	Unit	MBM250H33E3
Collector Emitter Voltage	V _{CEs}	V	3,300
Gate Emitter Voltage	V _{GES}	V	±20
Collector Current	DC	I _C	250(T _C =95°C)
	1ms	I _{CRM}	500
Forward Current	DC	I _F	250
	1ms	I _{FRM}	500
Peak Forward Surge Current	IFSM	A _p	2,000
Junction Temperature	T _{vj}	°C	-40 ~ +150
Junction Temperature	T _{vj op}	°C	-40 ~ +125
Case Temperature	T _C	°C	-40 ~ +125
Storage Temperature	T _{stg}	°C	-50 ~ +125
Isolation Voltage	V _{ISO}	V _{RMS}	7,700(AC 1 minute)
Screw Torque	Mounting (M6)	N·m	6 (1)

Notes: (1) Recommended Value 5.5±0.5N·m

ELECTRICAL CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	I _{CEs}	mA	-	-	2	V _{CE} =3,300V, V _{GE} =0V, T _{vj} =25°C
			-	4	10	V _{CE} =3,300V, V _{GE} =0V, T _{vj} =125°C
Gate Emitter Leakage Current	I _{GES}	nA	-500	-	+500	V _{GE} =±20V, V _{CE} =0V, T _{vj} =25°C
Collector Emitter Saturation Voltage	V _{CE(sat)}	V	-	2.65	-	T _{vj} =25°C
			2.70	3.40	3.90	T _{vj} =125°C
Gate Emitter Threshold Voltage	V _{GE(th)}	V	5.5	6.3	7.5	V _{CE} =10V, I _C =250mA, T _{vj} =25°C
Gate Charge	Q _g	uC	-	2.8	-	V _{CC} =1,800V, I _C =250A, V _{GE} =±15V
Input Capacitance	C _{ies}	nF	-	33	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, T _{vj} =25°C
Output Capacitance	C _{oes}	nF	-	3.3	-	
Reverse transfer capacitance	C _{res}	nF	-	2.3	-	
Internal Gate Resistance	R _{G(int)}	Ω	-	5.4	-	V _{CE} =10V, V _{GE} =0V, f=100kHz, T _{vj} =25°C
Turn On Delay Time	t _{d(on)}	μs	-	0.7	-	V _{CC} =1,800V, I _C =250A
Rise Time	t _r		-	1.8	2.5	L _S =400nH
Turn Off Delay Time	t _{d(off)}		-	2.1	-	R _G =15/15Ω (2)
Fall Time	t _f		-	1.9	3.2	V _{GE} =±15V, T _{vj} =125°C
Forward Voltage Drop	V _F	V	2.3	2.9	3.3	I _F =250A, V _{GE} =0V, T _{vj} =125°C
Reverse Recovery Time	t _{rr}	μs	-	0.7	1.2	V _{CC} =1,800V, I _F =250A, L _S =100nH T _{vj} =125°C
Turn On Loss	E _{on(10%)}	J/P	-	0.43	0.58	V _{CC} =1,800V, I _C =250A, L _S =400nH
Turn Off Loss	E _{off(10%)}	J/P	-	0.37	0.50	R _G =15/15Ω (2)
Reverse Recovery Loss	E _{rr(10%)}	J/P	-	0.31	0.41	V _{GE} =±15V, T _{vj} =125°C
Partial discharge extinction voltage	V _e	V _{RMS}	3,500	-	-	f=50Hz, Q _{PD} ≤10pC(acc. to IEC 61287)
Stray inductance module	L _{SCE}	nH	-	140	-	Between C1- E2
Thermal Impedance	IGBT	R _{th(f-c)}	-	-	0.050	Junction to case
	FWD	R _{th(f-c)}	-	-	0.100	
Contact Thermal Impedance	R _{th(c-f)}	K/W	-	0.032	-	Case to fin (par 1 arm)

Notes: (2) R_G value is the test condition's value for evaluation of the switching times, not recommended value.

Please, determine the suitable R_G value after the measurement of switching waveforms (overshoot voltage, etc.) with appliance mounted.

- * Please contact our representatives at order.
- * For improvement, specifications are subject to change without notice.
- * For actual application, please confirm this spec sheet is the newest revision.

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MODULE MECHANICAL CHARACTERISTICS

Item	Unit	Characteristics	Conditions
Weight	g	840	
Creepage Distance	Between terminal	54	Collector-sense to Emitter-main
	Terminal-Base	64	
Clearance Distance	Between terminal	19	Collector-sense to Emitter-main
	Terminal-Base	35	
Resistance, Terminal-chip	R_{CC+EE}	1.5	Terminal to chip
Comparative Tracking Index (CTI)		600	
Module base plate Material		Cu	
Baseplate Thickness	mm	5	
Insulation plate Material		AlN	
Terminal Surface treatment		Ni plating	
Case Material		Poly-Phenilene Sulfide	

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DEFINITION OF TEST CIRCUIT

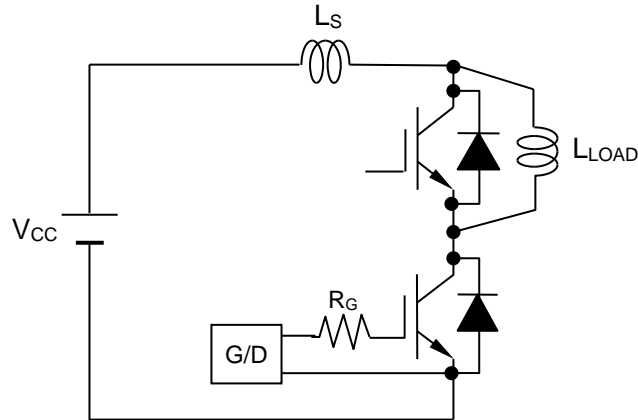


Fig.1 Switching test circuit

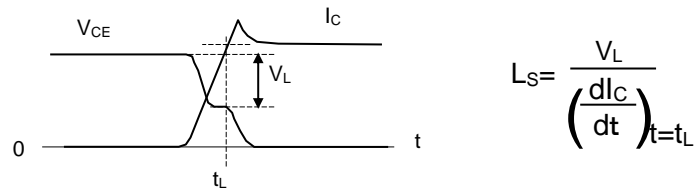


Fig.2 Definition of stray inductance

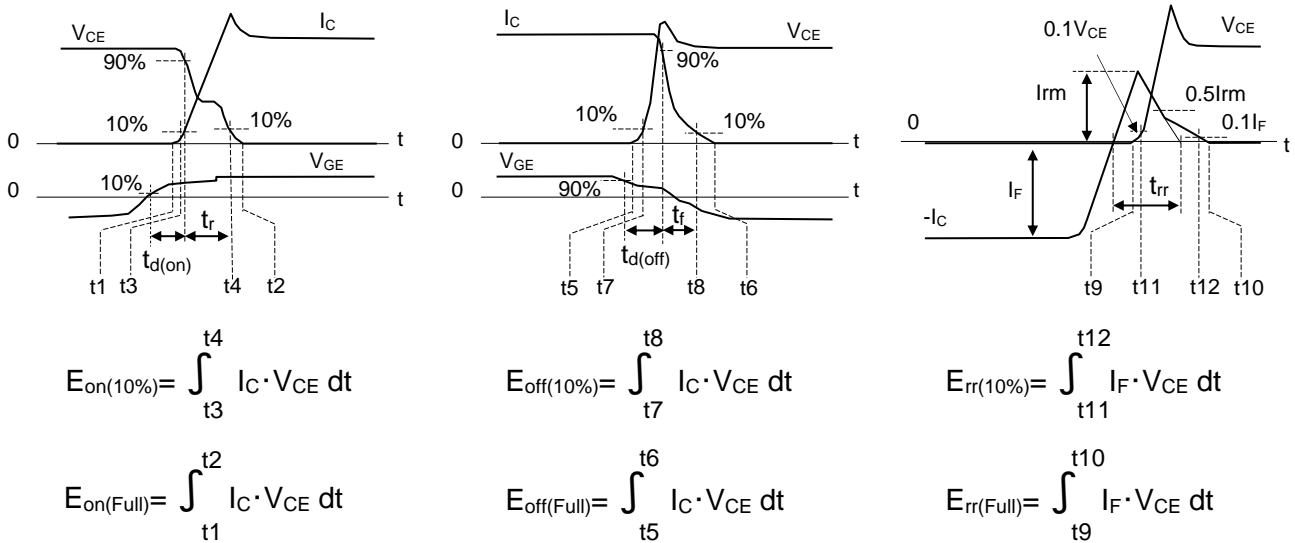
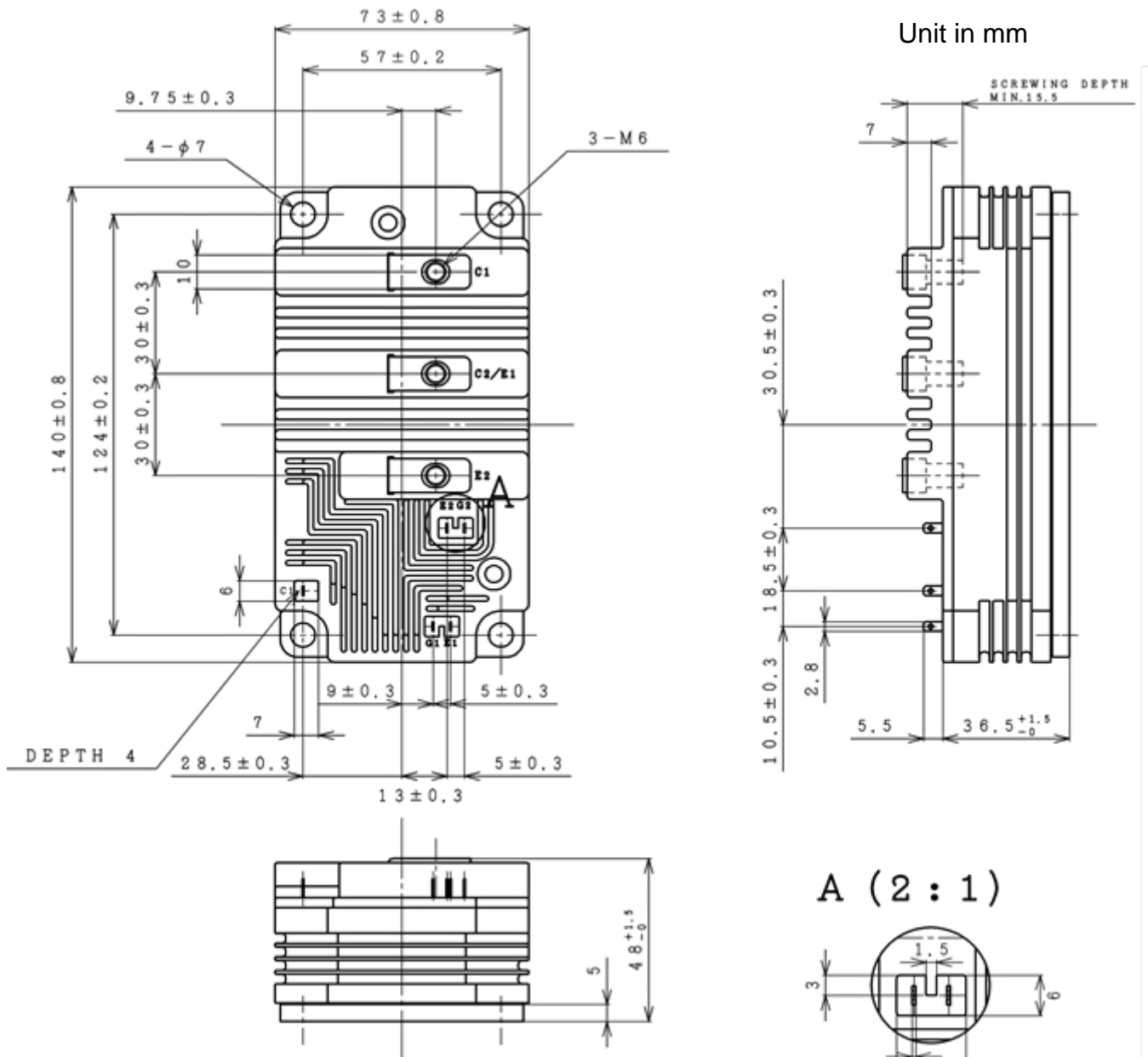


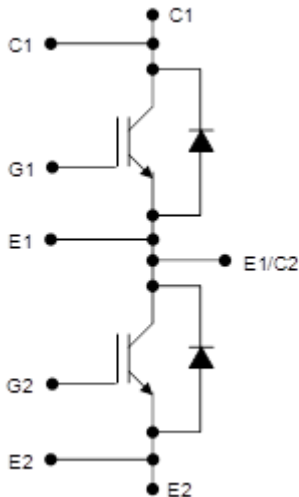
Fig.3 Definition of switching loss

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OUTLINE DRAWING

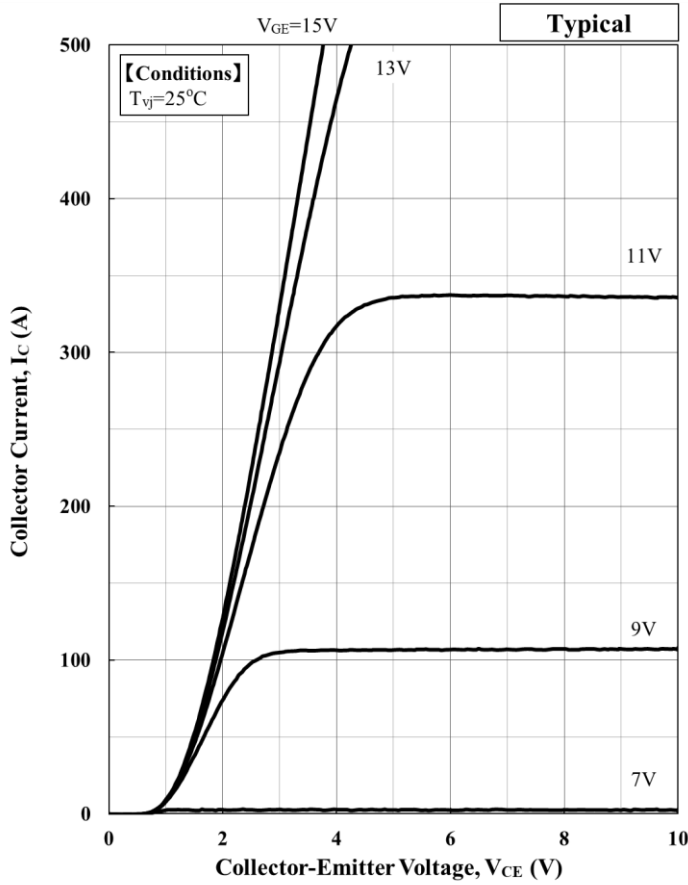


CIRCUIT DIAGRAM

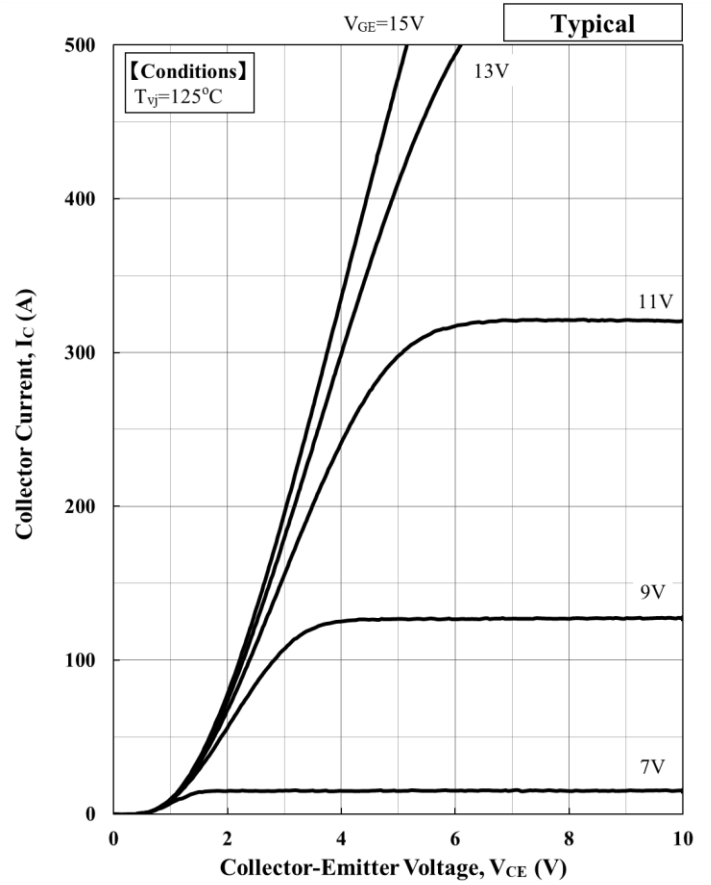


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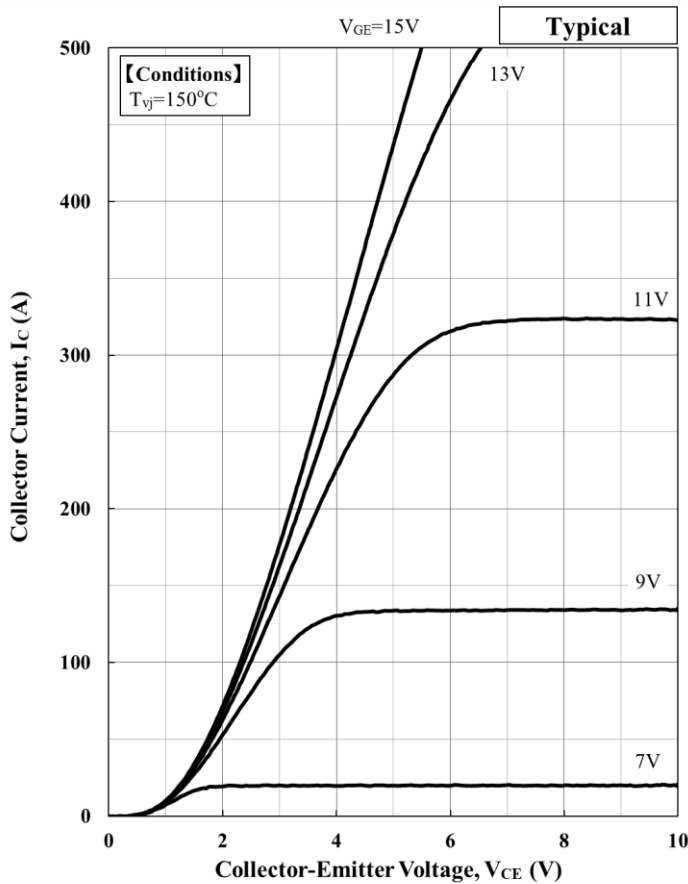
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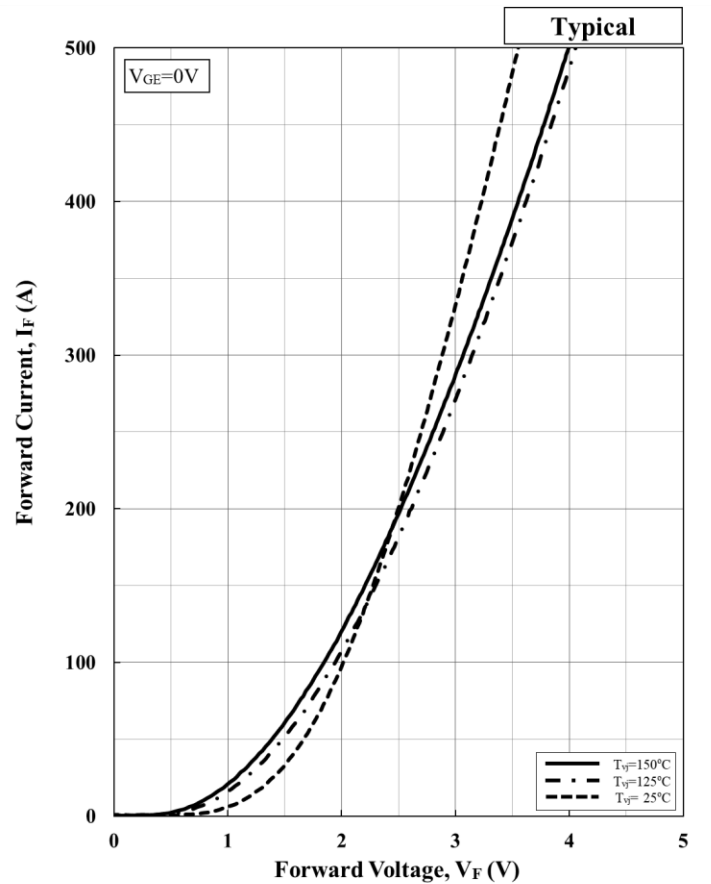
Collector Current vs. Collector Emitter Voltage



Collector Current vs. Collector Emitter Voltage

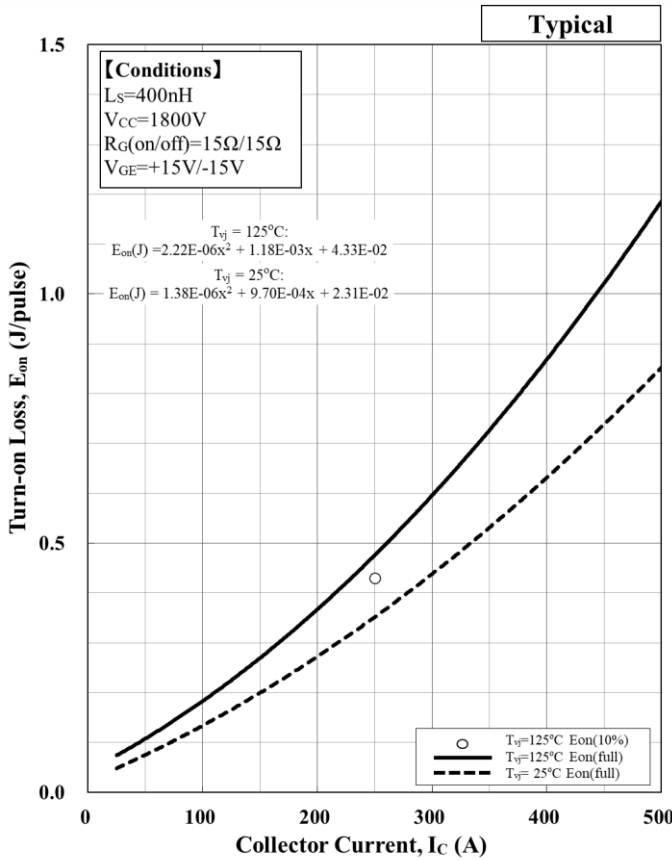


Collector Current vs. Collector Emitter Voltage

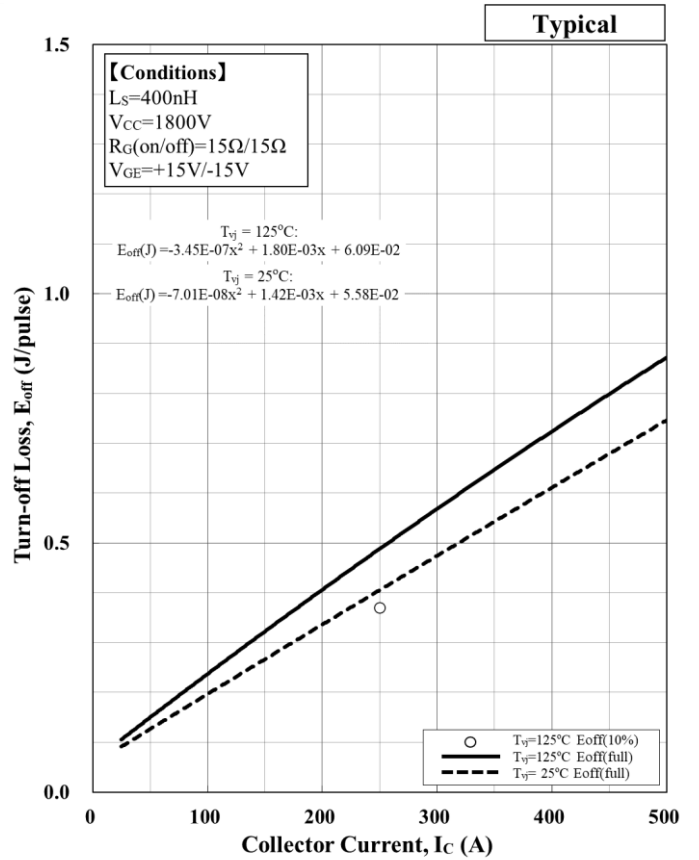


Forward Voltage of free-wheeling diode

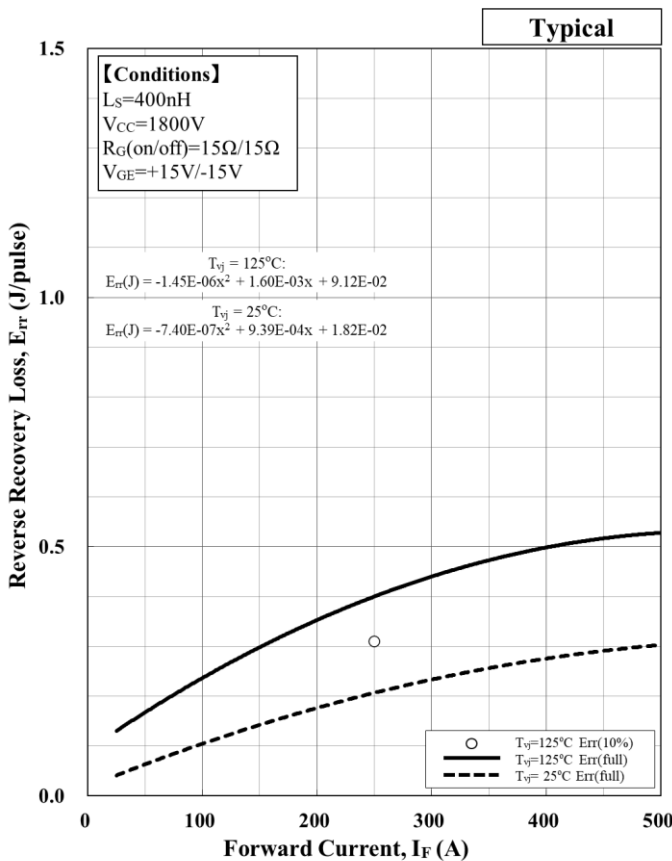
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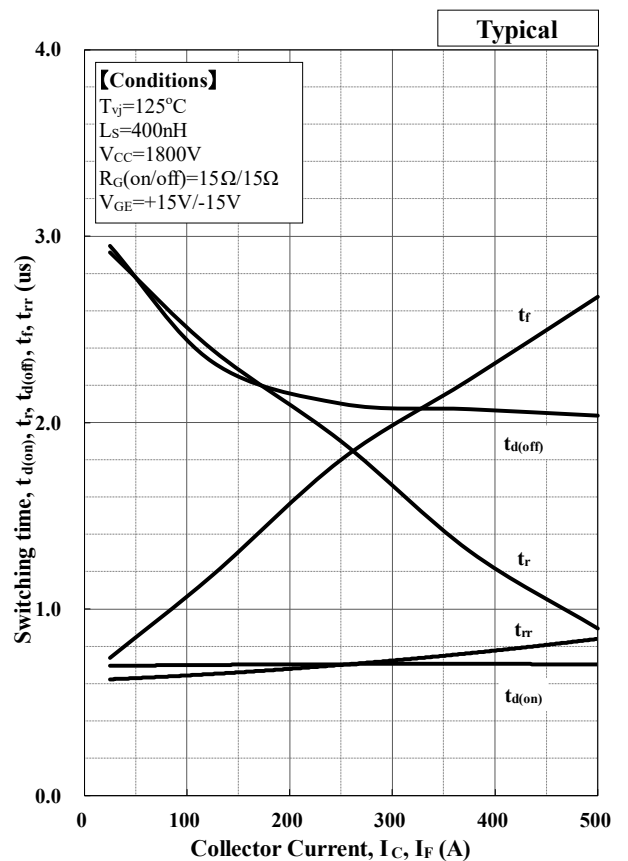
Turn-on loss vs. Collector current



Turn-off loss vs. Collector current

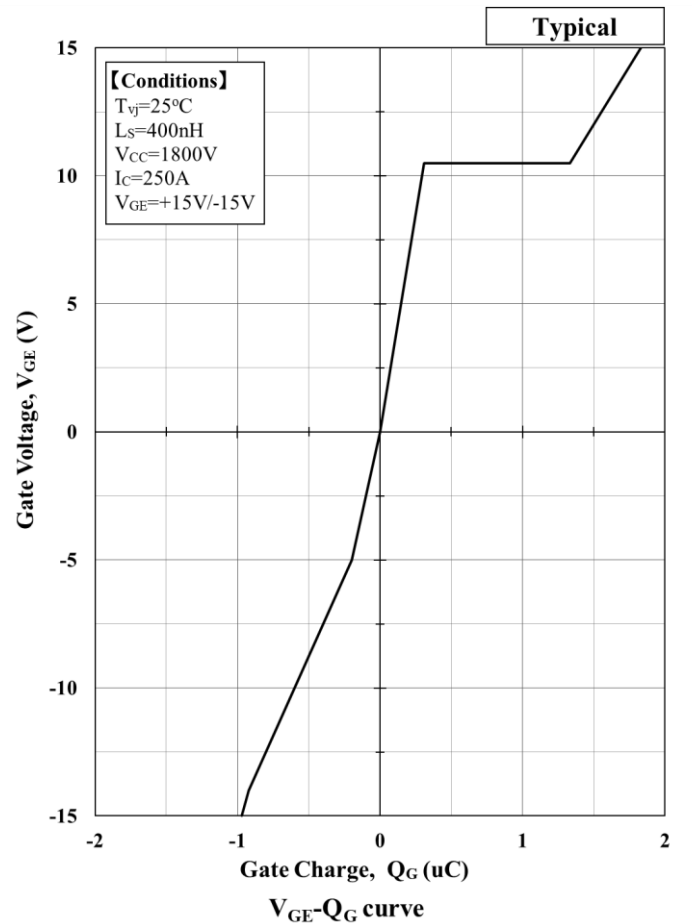
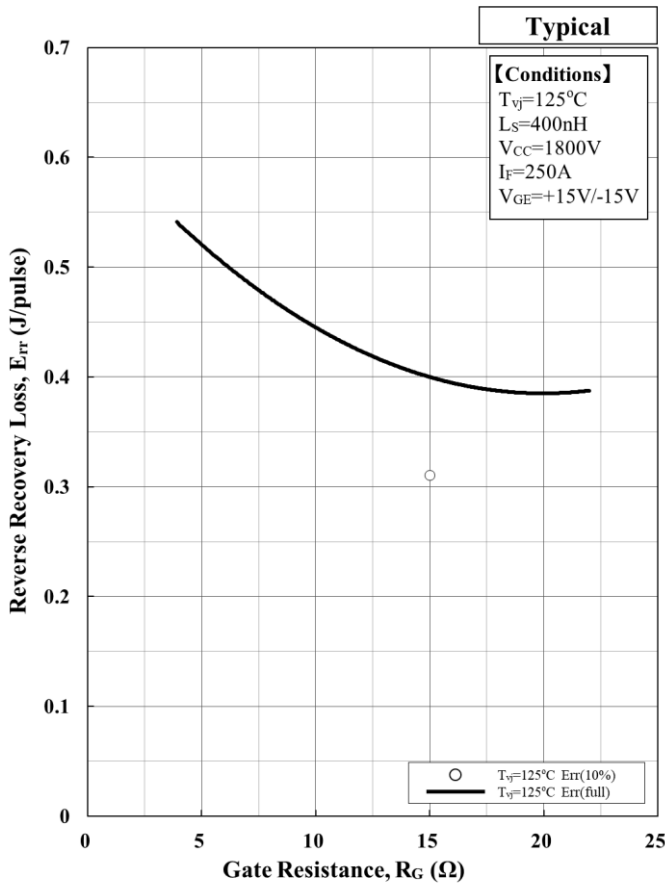
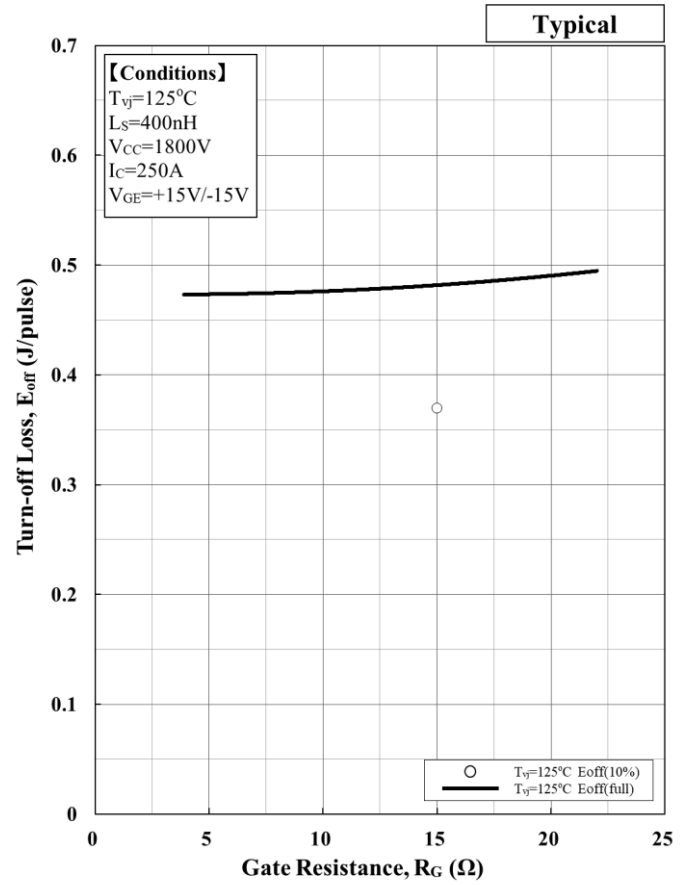
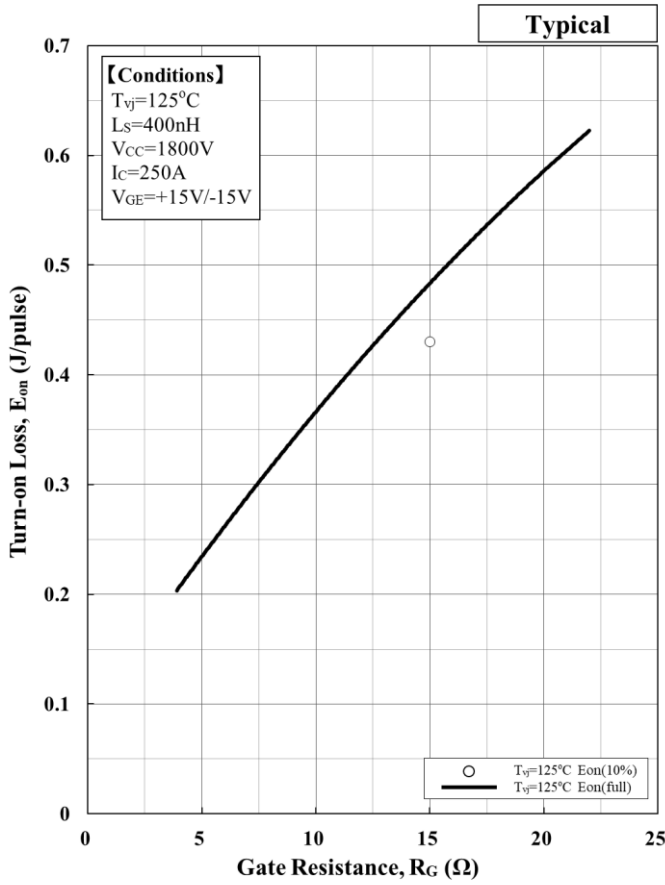


Reverse Recovery loss vs. Forward current



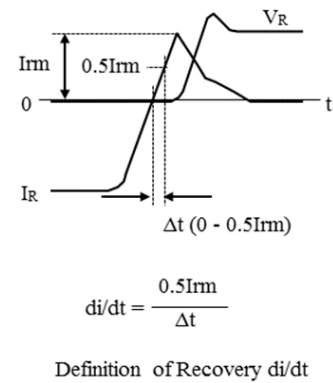
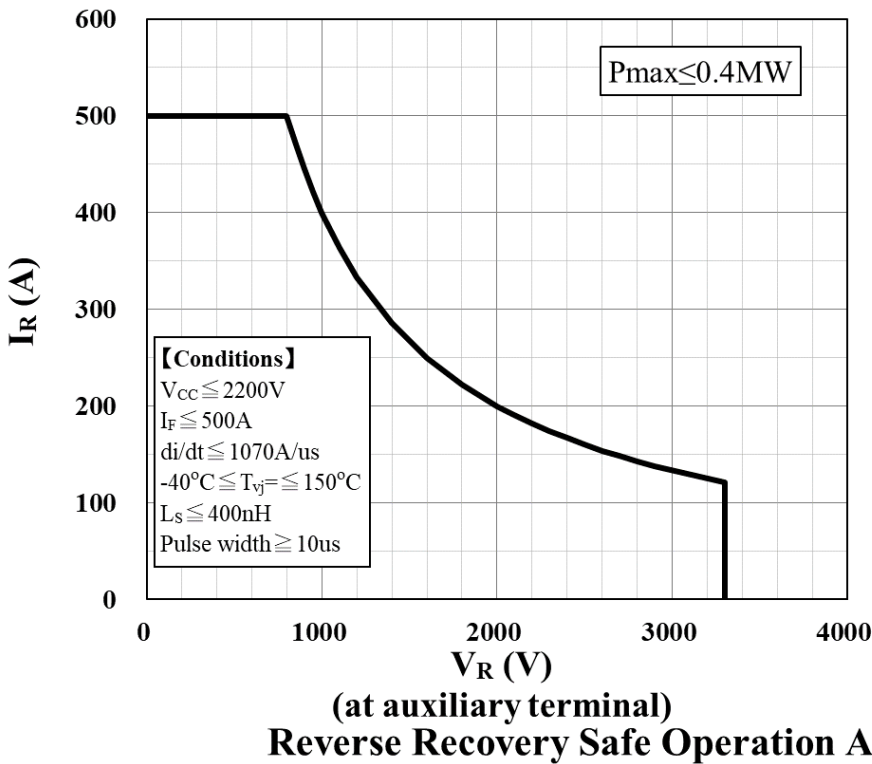
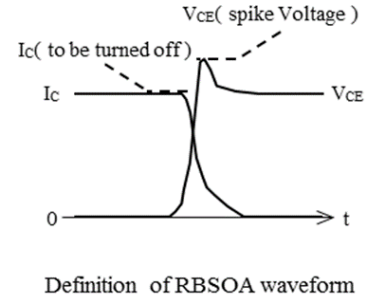
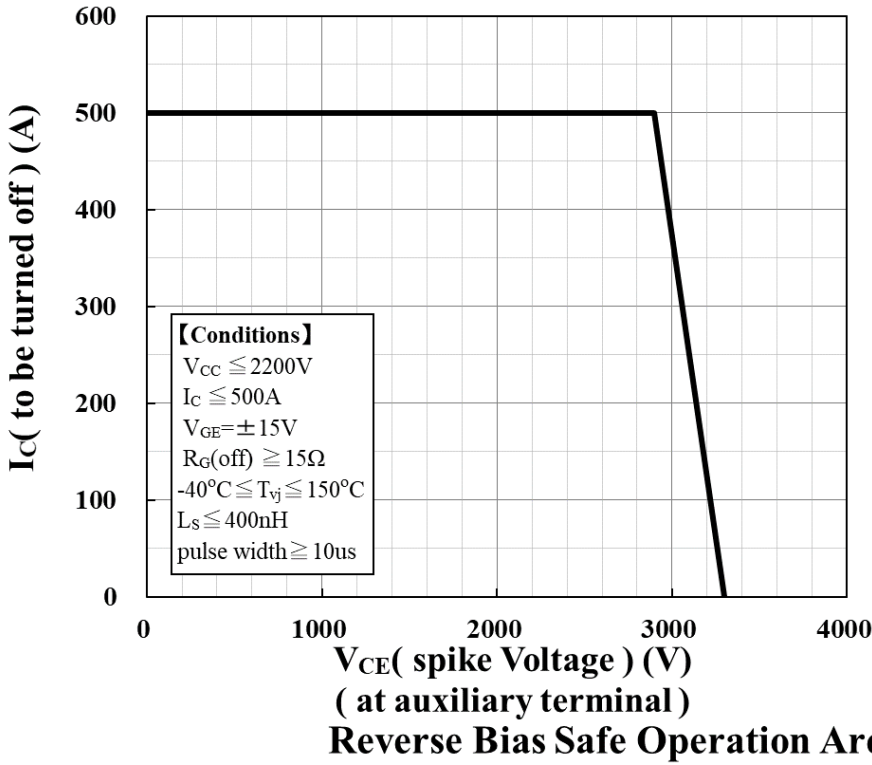
Switching time vs. Collector Current

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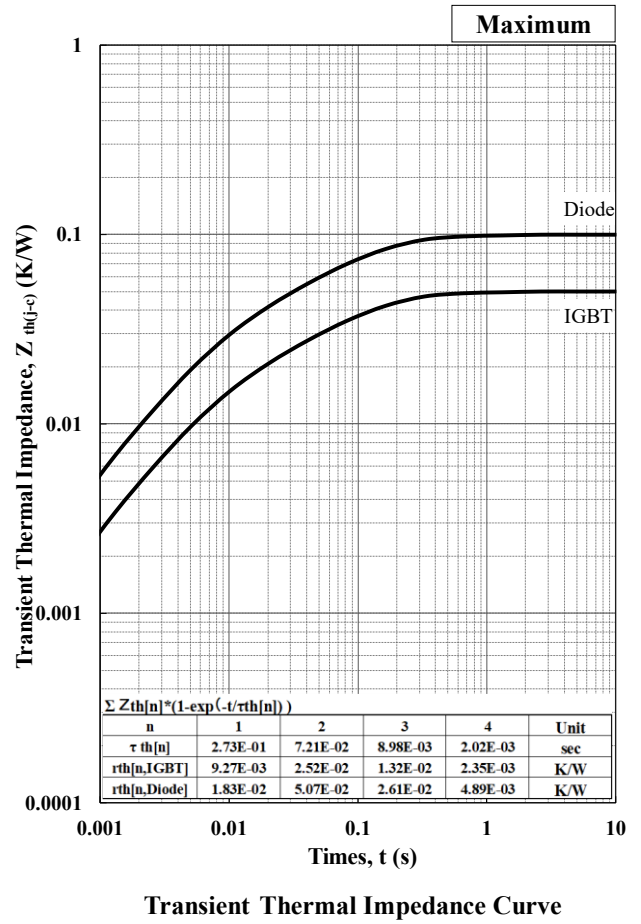
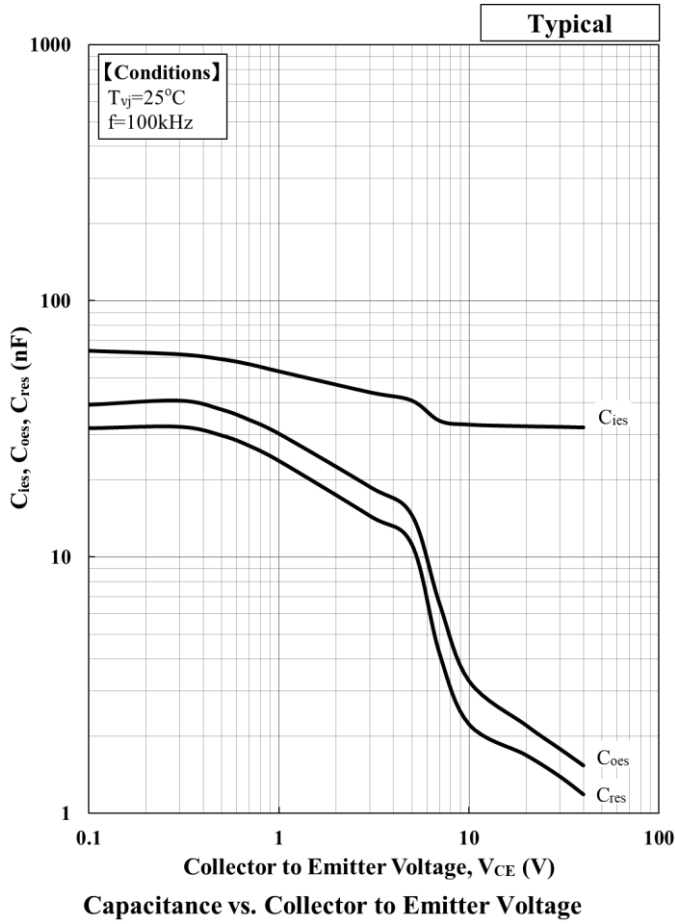


Reverse Recovery loss vs. Gate Resistance

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Material declaration

Please note the following materials are contained in the product, in order to keep characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder

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6. This specification is a material for component selection, which describes specifications of power semiconductor devices (hereinafter referred to as products), characteristic charts, and external dimension drawings.
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8. For handling other than described in this manual, follow the handling instructions (IGBT-HI-00002).

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Usage

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